

INTERNATIONAL STANDARD

IEC
61280-2-8

First edition
2003-02

Fibre optic communication subsystem test procedures – Digital systems

Part 2-8: Determination of low BER using Q-factor measurements

(<https://standards.iteh.ai>)
Document Preview

<https://standards.iteh.ai/standards/iec/88cb5fb4-a65c-4911-b6a7-b930e3271ddb/iec-61280-2-8-2003>

<https://standards.iteh.ai/standards/iec/88cb5fb4-a65c-4911-b6a7-b930e3271ddb/iec-61280-2-8-2003>



Reference number
IEC 61280-2-8:2003(E)

Publication numbering

As from 1 January 1997 all IEC publications are issued with a designation in the 60000 series. For example, IEC 34-1 is now referred to as IEC 60034-1.

Consolidated editions

The IEC is now publishing consolidated versions of its publications. For example, edition numbers 1.0, 1.1 and 1.2 refer, respectively, to the base publication, the base publication incorporating amendment 1 and the base publication incorporating amendments 1 and 2.

Further information on IEC publications

The technical content of IEC publications is kept under constant review by the IEC, thus ensuring that the content reflects current technology. Information relating to this publication, including its validity, is available in the IEC Catalogue of publications (see below) in addition to new editions, amendments and corrigenda. Information on the subjects under consideration and work in progress undertaken by the technical committee which has prepared this publication, as well as the list of publications issued, is also available from the following:

- **IEC Web Site** (www.iec.ch)

- **Catalogue of IEC publications**

The on-line catalogue on the IEC web site (http://www.iec.ch/searchpub/cur_fut.htm) enables you to search by a variety of criteria including text searches, technical committees and date of publication. On-line information is also available on recently issued publications, withdrawn and replaced publications, as well as corrigenda.

- **IEC Just Published**

This summary of recently issued publications (http://www.iec.ch/online_news/justpub/jp_entry.htm) is also available by email. Please contact the Customer Service Centre (see below) for further information.

- **Customer Service Centre**

If you have any questions regarding this publication or need further assistance, please contact the Customer Service Centre: -4911-b6a7-b930e3271ddb/iec-61280-2-8-2003

Email: custserv@iec.ch
Tel: +41 22 919 02 11
Fax: +41 22 919 03 00

INTERNATIONAL STANDARD

IEC 61280-2-8

First edition
2003-02

Fibre optic communication subsystem test procedures – Digital systems

Part 2-8: Determination of low BER using Q-factor measurements

(<https://standards.iteh.ai>)
Document Preview

<https://standards.iteh.ai/standards/iec/88cb5fb4-a65c-4911-b6a7-b930e3271ddb/iec-61280-2-8-2003>

<https://standards.iteh.ai/standards/iec/88cb5fb4-a65c-4911-b6a7-b930e3271ddb/iec-61280-2-8-2003>

© IEC 2003 — Copyright - all rights reserved

No part of this publication may be reproduced or utilized in any form or by any means, electronic or mechanical, including photocopying and microfilm, without permission in writing from the publisher.

International Electrotechnical Commission, 3, rue de Varembé, PO Box 131, CH-1211 Geneva 20, Switzerland
Telephone: +41 22 919 02 11 Telefax: +41 22 919 03 00 E-mail: inmail@iec.ch Web: www.iec.ch



Commission Electrotechnique Internationale
International Electrotechnical Commission
Международная Электротехническая Комиссия

PRICE CODE

U

For price, see current catalogue

CONTENTS

FOREWORD 4

1 Scope 5

2 Definitions and abbreviated terms 5

 2.1 Definitions 5

 2.2 Abbreviations 5

3 Measurement of low bit-error ratios 6

 3.1 General considerations 6

 3.2 Background to Q-factor 7

4 Variable decision threshold method 9

 4.1 Overview 9

 4.2 Apparatus 12

 4.3 Sampling and specimens 12

 4.4 Procedure 12

 4.5 Calculations and interpretation of results 13

 4.6 Test documentation 17

 4.7 Specification information 17

5 Variable optical threshold method 17

 5.1 Overview 17

 5.2 Apparatus 18

 5.3 Items under test 18

 5.4 Procedure for basic optical link 18

 5.5 Procedure for self-contained system 19

 5.6 Evaluation of results 20

Annex A (normative) Calculation of error bound in the value of Q 22

Annex B (informative) Sinusoidal interference method 24

Bibliography 30

Figure 1 – A sample eye diagram showing patterning effects 8

Figure 2 – A more accurate measurement technique using a DSO that samples the noise statistics between the eye centres 8

Figure 3 – Bit error ratio as a function of decision threshold level 10

Figure 4 – Plot of Q-factor as a function of threshold voltage 10

Figure 5 – Set-up for the variable decision threshold method 12

Figure 6 – Set-up of initial threshold level (approximately at the centre of the eye) 12

Figure 7 – Effect of optical bias 17

Figure 8 – Set-up for optical link or device test 19

Figure 9 – Set-up for system test 19

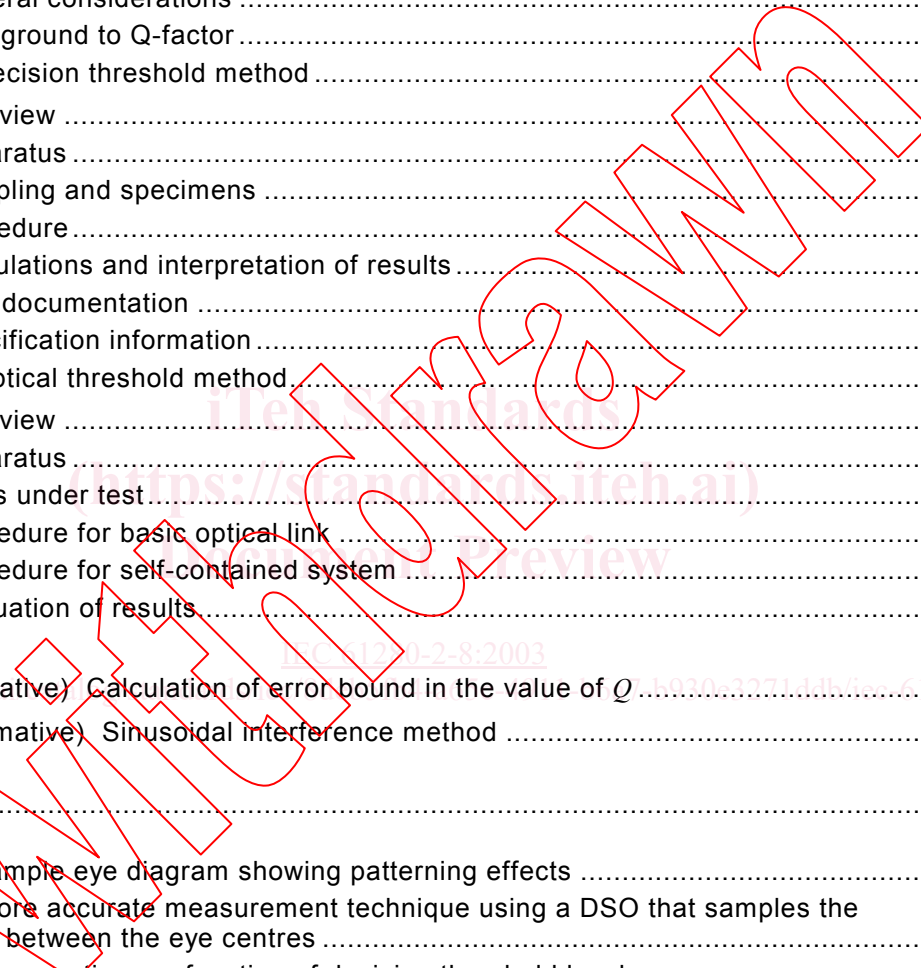
Figure 10 – Extrapolation of log BER as function of bias 21

Figure B.1 – Set-up for the sinusoidal interference method by optical injection 25

Figure B.2 – Set-up for the sinusoidal interference method by electrical injection 27

Figure B.3 – BER Result from the sinusoidal interference method (data points and extrapolated line) 28

Figure B.4 – BER versus optical power for three methods 29



<https://standards.iteh.ai/> IEC 61280-2-8:2003
<https://standards.iteh.ai/> IEC 61280-2-8:2003

Table 1 – Mean time for the accumulation of 15 errors as a function of BER and bit rate	6
Table 2 – BER as function of threshold voltage	14
Table 3 – f_i as a function of D_i	14
Table 4 – Values of linear regression constants	15
Table 5 – Mean and standard deviation	16
Table 6 – Example of optical bias test	20
Table B.1 – Results for sinusoidal injection	26

iTech Standards
(<https://standards.iteh.ai>)
Document Preview

<https://standards.iteh.ai/standards/iec/88cb5fb4-a65c-4911-b6a7-b930e3271ddb/iec-61280-2-8-2003>

<https://standards.iteh.ai/standards/iec/88cb5fb4-a65c-4911-b6a7-b930e3271ddb/iec-61280-2-8-2003>

INTERNATIONAL ELECTROTECHNICAL COMMISSION

FIBRE OPTIC COMMUNICATION SUBSYSTEM TEST PROCEDURES – DIGITAL SYSTEMS –

Part 2-8: Determination of low BER using Q-factor measurements

FOREWORD

- 1) The IEC (International Electrotechnical Commission) is a worldwide organisation for standardisation comprising all national electrotechnical committees (IEC National Committees). The object of the IEC is to promote international co-operation on all questions concerning standardisation in the electrical and electronic fields. To this end and in addition to other activities, the IEC publishes International Standards. Their preparation is entrusted to technical committees; any IEC National Committee interested in the subject dealt with may participate in this preparatory work. International, governmental and non-governmental organisations liaising with the IEC also participate in this preparation. The IEC collaborates closely with the International Organisation for Standardisation (ISO) in accordance with conditions determined by agreement between the two organisations.
2) The formal decisions or agreements of the IEC on technical matters express, as nearly as possible, an international consensus of opinion on the relevant subjects since each technical committee has representation from all interested National Committees.
3) The documents produced have the form of recommendations for international use and are published in the form of standards, technical specifications, technical reports or guides and they are accepted by the National Committees in that sense.
4) In order to promote international unification, IEC National Committees undertake to apply IEC International Standards transparently to the maximum extent possible in their national and regional standards. Any divergence between the IEC Standard and the corresponding national or regional standard shall be clearly indicated in the latter.
5) The IEC provides no marking procedure to indicate its approval and cannot be rendered responsible for any equipment declared to be in conformity with one of its standards.
6) Attention is drawn to the possibility that some of the elements of this International Standard may be the subject of patent rights. The IEC shall not be held responsible for identifying any or all such patent rights.

International Standard IEC 61280-2-8 has been prepared by subcommittee 86C: Fibre optic systems and active devices, of IEC technical committee 86: Fibre optics.

The text of this standard is based on the following documents:

Table with 2 columns: FDIS, Report on voting. Row 1: 86C/485/FDIS, 86C/505/RVD

Full information on the voting for the approval of this standard can be found in the report on voting indicated in the above table.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

The committee has decided that the contents of this publication will remain unchanged until 2010. At this date, the publication will be

- reconfirmed;
withdrawn;
replaced by a revised edition, or
amended.

FIBRE OPTIC COMMUNICATION SUBSYSTEM TEST PROCEDURES – DIGITAL SYSTEMS –

Part 2-8: Determination of low BER using Q-factor measurements

1 Scope

This part of IEC 61280 specifies two main methods for the determination of low BER values by making accelerated measurements. These include the variable decision threshold method (Clause 4) and the variable optical threshold method (Clause 5). In addition, a third method, the sinusoidal interference method, is described in Annex B.

2 Definitions and abbreviated terms

2.1 Definitions

For the purposes of this document, the following terms and definitions apply.

2.1.1

amplified spontaneous emission

ASE

impairment generated in optical amplifiers

2.1.2

bit error ratio

BER

the number bits in error as a ratio of the total number of bits

2.1.3

intersymbol interference

ISI

mutual interference between symbols in a data stream, usually caused by non-linear effects and bandwidth limitations of the transmission path

2.1.4

Q-factor

Q

ratio of the difference between the mean voltage of the 1 and 0 rails, and the sum of their standard deviation values

2.2 Abbreviations

cw	Continuous wave (normally referring to a sinusoidal wave form)
DC	Direct current
DSO	Digital sampling oscilloscope
DUT	Device under test
PRBS	Pseudo-random binary sequence

3 Measurement of low bit-error ratios

3.1 General considerations

Fibre optic communication systems and subsystems are inherently capable of providing exceptionally good error performance, even at very high bit rates. The mean bit error ratio (BER) may typically lie in the region 10^{-12} to 10^{-20} , depending on the nature of the system. While this type of performance is well in excess of practical performance requirements for digital signals, it gives the advantage of concatenating many links over long distances without the need to employ error correction techniques.

The measurement of such low error ratios presents special problems in terms of the time taken to measure a sufficiently large number of errors to obtain a statistically significant result. Table 1 presents the mean time required to accumulate 15 errors. This number of errors can be regarded as statistically significant, offering a confidence level of 75 % with a variability of 50 %.

Table 1 – Mean time for the accumulation of 15 errors as a function of BER and bit rate

BER Bits/s	10^{-6}	10^{-7}	10^{-8}	10^{-9}	10^{-10}	10^{-11}	10^{-12}	10^{-13}	10^{-14}	10^{-15}
1,0M	1,5 s	15 s	2,5 min	25 min	4,2 h	1,7 d	17 d	170 d	4,7 years	47 years
2,0M	750 ms	7,5 s	75 s	750 s	2,1 h	21 h	8,8 d	88 d	2,4 years	24 years
10M	150 ms	1,5 s	15 s	2,5 min	25 min	4,2 h	1,7 d	17 d	170 d	4,7 years
50M	30 ms	300 ms	3,0 s	30 s	5,0 min	50 min	8,3 h	3,5 d	35 d	350 d
100M	15 ms	150 ms	1,5 s	15 s	2,5 min	25 min	4,2 h	1,7 d	17 d	170 d
500M	3 ms	30 ms	300 ms	3,0 s	30 s	5,0 min	50 min	8,3 h	3,5 d	35 d
1,0G	1,5 ms	15 ms	150 ms	1,5 s	15 s	2,5 min	25 min	4,2 h	1,7 d	17 d
10G	150 μ s	1,5 ms	15 ms	150 ms	1,5 s	15 s	2,5 min	25 min	4,2 h	1,7 d
40G	38 μ s	380 μ s	3,8 ms	38 ms	380 ms	3,8 s	38 s	6,3 min	63 min	10,4 h
100G	15 μ s	150 μ s	1,5 ms	15 ms	150 ms	1,5 s	15 s	2,5 min	25 min	4,2 h

The times given in Table 1 show that the direct measurement of the low BER values expected from fibre optic systems is not practical during installation and maintenance operations. One way of overcoming this difficulty is to artificially impair the signal-to-noise ratio at the receiver in a controlled manner, thus significantly increasing the BER and reducing the measurement time. The error performance is measured for various levels of impairment, and the results are then extrapolated to a level of zero impairment using computational or graphical methods according to theoretical or empirical regression algorithms.

The difficulty presented by the use of any regression technique for the determination of the error performance is that the theoretical BER value is related to the level of impairment via the inverse error function (*erfc*). This means that very small changes in the impairment lead to very large changes in BER; for example, in the region of a BER value of 10^{-15} a change of approximately 1 dB in the level of impairment results in a change of three orders of magnitude in the BER. A further difficulty is that a method based on extrapolation is unlikely to reveal a levelling off of the BER at only about 3 orders of magnitude below the lowest measured value.

It should also be noted that, in the case of digitally regenerated sections, the results obtained apply only to the regenerated section whose receiver is under test. Errors generated in upstream regenerated sections may generate an error plateau which may have to be taken into account in the error performance evaluation of the regenerator section under test.

As noted above, two main methods for the determination of low BER values by making accelerated measurements are described. These are the variable decision threshold method (Clause 4) and the variable optical threshold method (Clause 5). In addition, a third method, the sinusoidal interference method, is described in Annex B.

It should be noted that these methods are applicable to the determination of the error performance in respect of amplitude-based impairments. Jitter may also affect the error performance of a system, and its effect requires other methods of determination. If the error performance is dominated by jitter impairments, the amplitude-based methods described in this standard will lead to BER values which are lower than the actual value.

The variable decision threshold method is the procedure which can most accurately measure the Q-factor and the BER for optical systems with unknown or unpredictable noise statistics. A key limitation, however, to the use of the variable threshold method to measure Q-factor and BER is the need to have access to the receiver electronics in order to manipulate the decision threshold. For systems where such access is not available it may be useful to utilize the alternative variable optical threshold method. Both methods are capable of being automated in respect of measurement and computation of the results

3.2 Background to Q-factor

The Q-factor is the signal-to-noise ratio (SNR) at the decision circuit and is typically expressed as [3]¹:

$$Q = \frac{\mu_1 - \mu_0}{\sigma_1 + \sigma_0} \quad (1)$$

where μ_1 and μ_0 are the mean voltage levels of the “1” and “0” rails, respectively, and σ_1 and σ_0 are the standard deviation values of the noise distribution on the “1” and “0” rails, respectively.

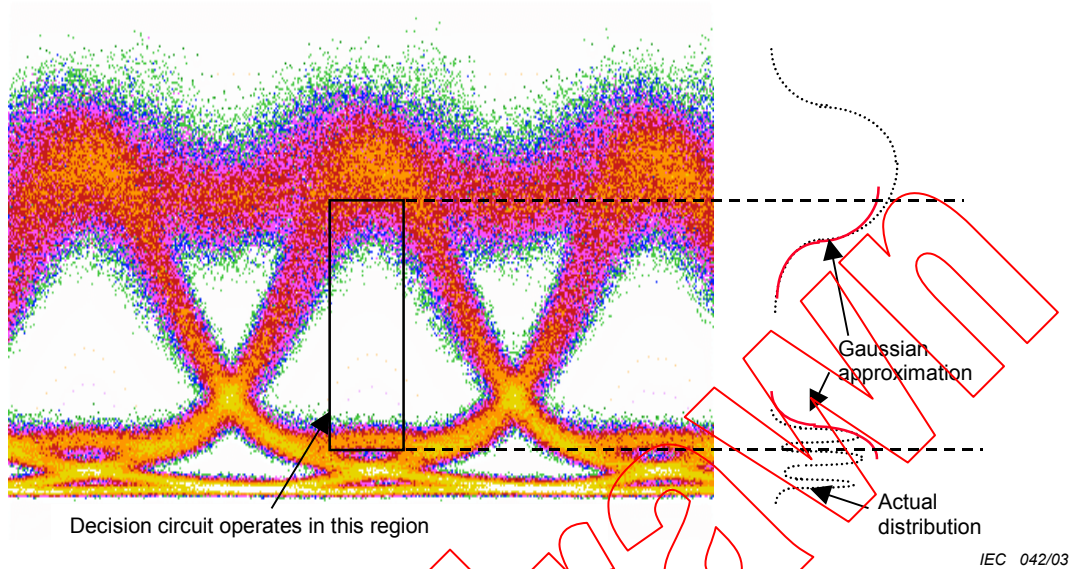
An accurate estimation of a system's transmission performance, or Q-factor, must take into consideration the effects of all sources of performance degradation, both fundamental and those due to real-world imperfections. Two important sources are amplified spontaneous emission (ASE) noise and intersymbol interference (ISI). Additive noise originates primarily from ASE of optical amplifiers. ISI arises from many effects, such as chromatic dispersion, fibre non-linearities, multi-path interference, polarization-mode dispersion and use of electronics with finite bandwidth. There may be other effects as well, for example, a poor impedance match can cause impairments such as long fall times or ringing on a waveform.

One possible method to measure Q-factor is the voltage histogram method in which a digital sampling oscilloscope is used to measure voltage histograms at the centre of a binary eye to estimate the waveform's Q-factor [4]. In this method, a pattern generator is used as a stimulus and the oscilloscope is used to measure the received eye opening and the standard deviation of the noise present in both voltage rails. As a rough approximation, the edge of visibility of the noise represents the 3σ points of an assumed Gaussian distribution. The advantage of using an oscilloscope to measure the eye is that it can be done rapidly on real traffic with a minimum of equipment.

The oscilloscope method for measuring the Q-factor has several shortcomings. When used to measure the eye of high-speed data (of the order of several Gbit/s), the oscilloscope's limited digital sampling rate (often in the order of a few hundred kilohertz) allows only a small minority of the high-speed data stream to be used in the Q-factor measurement. Longer observation times could reduce the impact of the slow sampling. A more fundamental shortcoming is that the Q estimates derived from the voltage histograms at the eye centre are often inaccurate. Various patterning effects and added noise from the front-end electronics of the oscilloscope can often obscure the real variance of the noise.

¹ Figures in square brackets refer to the bibliography.

Figure 1 shows a sample eye diagram made on an operating system. It can be seen in this figure that the vertical histograms through the centre of the eye show patterning effects (less obvious is the noise added by the front-end electronics of the oscilloscope). It is difficult to predict the relationship between the Q measured this way and the actual BER measured with a test set.



NOTE The data for measuring the Q-factor is obtained from the tail of the Gaussian distributions.

Figure 1 – A sample eye diagram showing patterning effects

Figure 2 shows another possible way of measuring Q-factor using an oscilloscope. The idea is to use the centre of the eye to estimate the eye opening and use the area between eye centres to estimate the noise. Pattern effect contributions to the width of the histogram would then be reduced. A drawback to this method is that it relies on measurements made on a portion of the eye that the receiver does not really ever use.

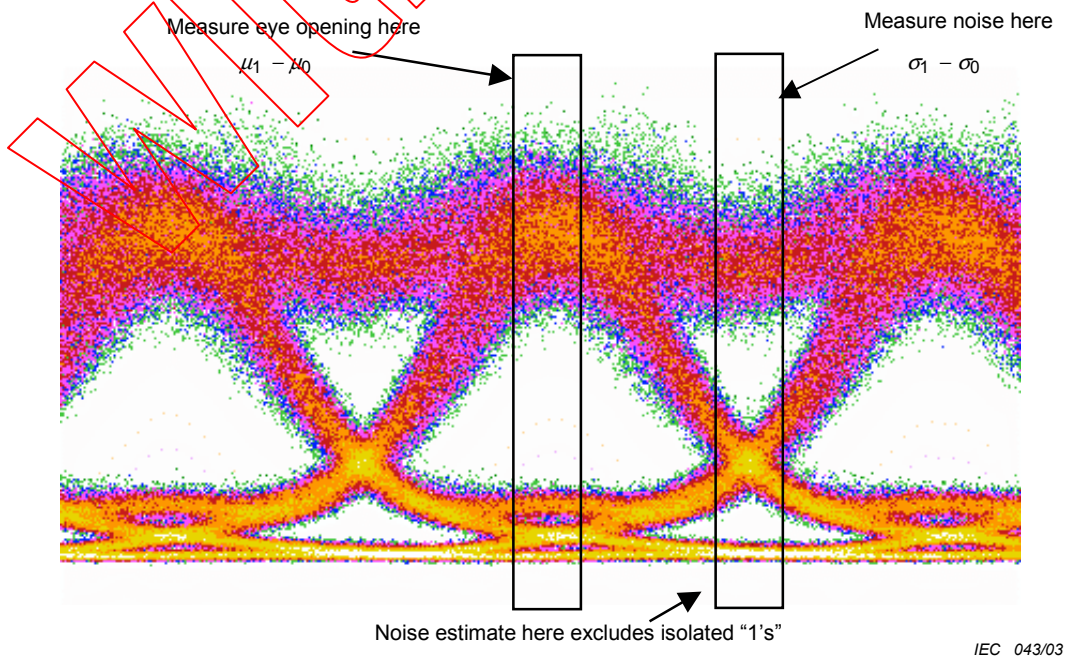


Figure 2 – A more accurate measurement technique using a DSO that samples the noise statistics between the eye centres

It is tempting to conclude that the estimates for σ_1 and σ_0 would tend to be overestimated and that the resulting Q measurements would always form a lower bound to the actual Q for either of these oscilloscope-based methods. That is not necessarily the case. It is possible that the histogram distributions can be distorted in other ways, for example, skewed in such a way that the mean values overestimate the eye opening – and the resulting Q will actually not be a lower bound. There is, unfortunately, no easily characterized relationship between oscilloscope-derived Q measurements and BER performance.

4 Variable decision threshold method

4.1 Overview

This method of estimating the Q-factor relies on using a receiver front-end with a variable decision threshold. Some means of measuring the BER of the system is required. Typically the measurement is performed with an error test set using a pseudo-random binary sequence (PRBS), but there are alternate techniques which allow operation with live traffic. The measurement relies on the fact that for a data eye with Gaussian statistics, the BER may be calculated analytically as follows:

$$BER(V_{th}) = \frac{1}{2} \left(\operatorname{erfc} \left(\frac{|V_{th} - \mu_1|}{\sigma_1} \right) + \operatorname{erfc} \left(\frac{|V_{th} - \mu_0|}{\sigma_0} \right) \right) \quad (2)$$

where

μ_1, μ_0 and σ_1, σ_0 are the mean and standard deviation of the “1” and “0” data rails;

V_{th} is the decision threshold level;

$\operatorname{erfc}(\cdot)$ is the complementary error function given by

$$\operatorname{erfc}(x) = \frac{1}{\sqrt{2\pi}} \int_x^{\infty} e^{-\beta^2/2} d\beta \cong \frac{1}{x\sqrt{2\pi}} e^{-x^2/2} \quad (3)$$

(The approximation is nearly exact for $x > 3$.)

The BER, given in equation 2, is the sum of two terms. The first term is the conditional probability of deciding that a “0” has been received when a “1” has been sent, and the second term is the probability of deciding that a “1” has been received when a “0” has been sent.

In order to implement this technique, the BER is measured as a function of the threshold voltage (see Figure 3). Equation 2 is then used to convert the data into a plot of the Q-factor versus threshold, where the Q-factor is the argument of the complementary error function of either term in equation 2. To make the conversion, the approximation is made that the BER is dominated by only one of the terms in equation 2 according to whether the threshold is closer to the “1’s” or the “0’s” rail of the eye diagram.